

PMR290UNE

20 V, 700 mA N-channel Trench MOSFET Rev. 1 — 13 September 2011

Product data sheet

Product profile

1.1 General description

N-channel enhancement mode Field-Effect Transistor (FET) in a small SOT416 (SC-75) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

1.2 Features and benefits

- Very fast switching
- Trench MOSFET technology
- ESD protection up to 2 kV
- AEC-Q101 qualified

1.3 Applications

- Relay driver
- High-speed line driver

- Low-side loadswitch
- Switching circuits

1.4 Quick reference data

Table 1. **Quick reference data**

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{DS}	drain-source voltage	T _j = 25 °C		-	-	20	V
V_{GS}	gate-source voltage			-8	-	8	V
I _D	drain current	$V_{GS} = 4.5 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}$	<u>[1]</u>	-	-	700	mA
Static charact	eristics						
R _{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 500 \text{ mA}; T_j = 25 \text{ °C}$		-	290	380	mΩ

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm².



017aaa255

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2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	S	source	<u> </u>	D
3	D	drain	1 2 SOT416 (SC-75)	G

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PMR290UNE	SC-75	plastic surface-mounted package; 3 leads	SOT416

4. Marking

Table 4. Marking codes

Type number	Marking code
PMR290UNE	AC

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Parameter	Conditions		Min	Max	Unit
drain-source voltage	T _j = 25 °C		-	20	V
gate-source voltage			-8	8	V
drain current	V _{GS} = 4.5 V; T _{amb} = 25 °C	<u>[1]</u>	-	700	mΑ
	V _{GS} = 4.5 V; T _{amb} = 100 °C	<u>[1]</u>	-	440	mA
peak drain current	$T_{amb} = 25 ^{\circ}C$; single pulse; $t_p \le 10 \mu s$		-	2.8	Α
total power dissipation	T _{amb} = 25 °C	[2]	-	250	mW
		[1]	-	300	mW
	T _{sp} = 25 °C		-	770	mW
junction temperature			-55	150	°C
ambient temperature			-55	150	°C
storage temperature			-65	150	°C
diode					
source current	T _{amb} = 25 °C	<u>[1]</u>	-	300	mA
n rating					
electrostatic discharge voltage	НВМ	[3]	-	2000	V
	drain-source voltage gate-source voltage drain current peak drain current total power dissipation junction temperature ambient temperature storage temperature diode source current rating	$ \begin{array}{lll} drain\text{-source voltage} & T_j = 25 \ ^{\circ}\text{C} \\ gate\text{-source voltage} \\ drain current & V_{GS} = 4.5 \ ^{\circ}\text{C}, \ T_{amb} = 25 \ ^{\circ}\text{C} \\ \hline V_{GS} = 4.5 \ ^{\circ}\text{C}, \ T_{amb} = 100 \ ^{\circ}\text{C} \\ \hline Peak drain current & T_{amb} = 25 \ ^{\circ}\text{C}; \ single pulse; \ t_p \leq 10 \ \mu s \\ \hline total power dissipation & T_{amb} = 25 \ ^{\circ}\text{C} \\ \hline Junction temperature & \\ ambient temperature & \\ storage temperature & \\ \hline storage temperature & \\ \hline source current & T_{amb} = 25 \ ^{\circ}\text{C} \\ \hline 1 & 1 & 1 & 1 & 1 & 1 \\ \hline 1 & 1 & 1 & 1 & 1 \\ \hline 1 & 1 & 1 & 1 & 1 & 1 \\$	$ \begin{array}{c} \text{drain-source voltage} \\ \text{gate-source voltage} \\ \text{drain current} \\ & \begin{array}{c} V_{GS} = 4.5 \text{ V}; T_{amb} = 25 \text{ °C} \\ \hline V_{GS} = 4.5 \text{ V}; T_{amb} = 100 \text{ °C} \\ \hline V_{GS} = 4.5 \text{ V}; T_{amb} = 100 \text{ °C} \\ \hline 11 \\ \text{peak drain current} \\ \text{total power dissipation} \\ \hline T_{amb} = 25 \text{ °C}; \text{single pulse}; t_p \leq 10 \text{ µs} \\ \hline 11 \\ \hline T_{sp} = 25 \text{ °C} \\ \hline \text{junction temperature} \\ \text{ambient temperature} \\ \text{storage temperature} \\ \hline \text{storage temperature} \\ \hline \text{source current} \\ \hline T_{amb} = 25 \text{ °C} \\ \hline \end{array} $	$ \begin{array}{c} drain\text{-source voltage} \\ gate\text{-source voltage} \\ drain current \\ \hline \\ V_{GS} = 4.5 \text{ V}; T_{amb} = 25 ^{\circ}\text{C} \\ \hline \\ V_{GS} = 4.5 \text{ V}; T_{amb} = 100 ^{\circ}\text{C} \\ \hline \\ V_{GS} = 4.5 \text{ V}; T_{amb} = 100 ^{\circ}\text{C} \\ \hline \\ 11 \\ \hline$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm².
- [2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.
- [3] Measured between all pins.

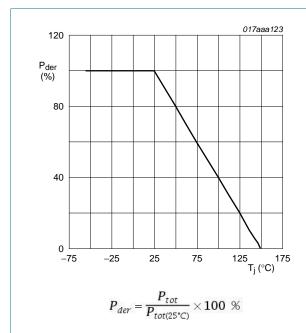
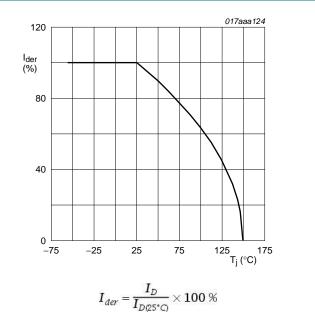
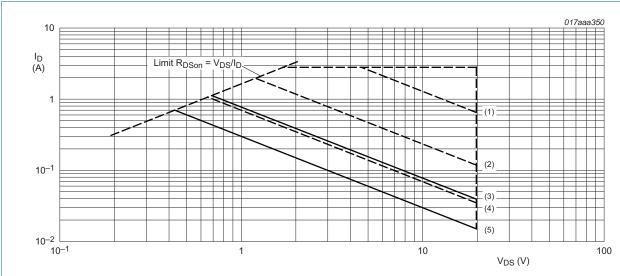


Fig 1. Normalized total power dissipation as a function of junction temperature



ig 2. Normalized continuous drain current as a function of junction temperature

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I_{DM} = single pulse

- (1) $t_p = 1 \text{ ms}$
- (2) $t_p = 10 \text{ ms}$
- (3) DC; $T_{sp} = 25 \, ^{\circ}\text{C}$
- (4) $t_p = 100 \text{ ms}$
- (5) DC; $T_{amb} = 25 \, ^{\circ}C$; drain mounting pad 1 cm²

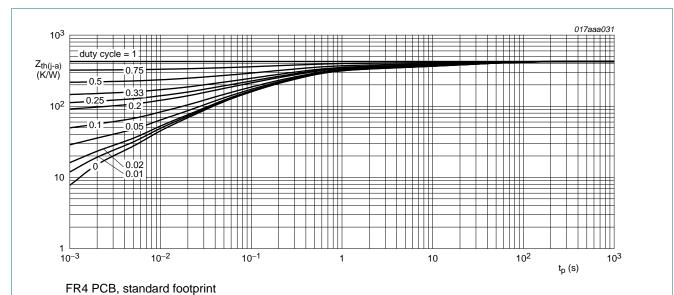
Fig 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage

Thermal characteristics

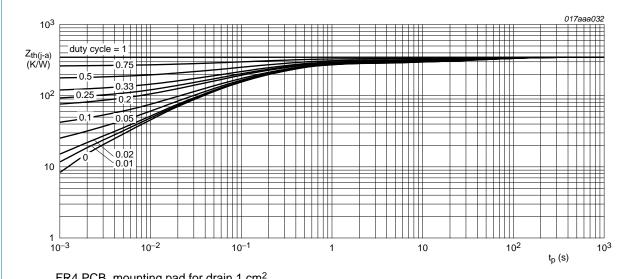
Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance	in free air	<u>[1]</u>	-	440	510	K/W
	from junction to ambient		[2]	-	360	415	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point			-	-	160	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm².



Transient thermal impedance from junction to ambient as a function of pulse duration; typical values Fig 4.



FR4 PCB, mounting pad for drain 1 cm²

Transient thermal impedance from junction to ambient as a function of pulse duration; typical values Fig 5.

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7. Characteristics

Table 7. Characteristics

Table 7.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	20	-	-	V
V_{GSth}	gate-source threshold voltage	$I_D = 250 \mu A; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	0.5	0.75	0.95	V
I _{DSS}	drain leakage current	$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	1	μΑ
		$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$	-	-	10	μΑ
I _{GSS}	gate leakage current	$V_{GS} = 8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	-	2	μΑ
		$V_{GS} = -8 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	2	μΑ
		$V_{GS} = 4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	500	nΑ
		$V_{GS} = -4.5 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	500	nA
R _{DSon}	drain-source on-state	$V_{GS} = 4.5 \text{ V}; I_D = 500 \text{ mA}; T_j = 25 \text{ °C}$	-	290	380	mΩ
	resistance	$V_{GS} = 4.5 \text{ V}; I_D = 500 \text{ mA}; T_j = 150 \text{ °C}$	-	460	610	mΩ
		$V_{GS} = 2.5 \text{ V}; I_D = 400 \text{ mA}; T_j = 25 \text{ °C}$	-	420	620	mΩ
		$V_{GS} = 1.8 \text{ V}; I_D = 100 \text{ mA}; T_j = 25 \text{ °C}$	-	600	1100	mΩ
g _{fs}	forward transconductance	$V_{DS} = 10 \text{ V}; I_D = 200 \text{ mA}; T_j = 25 \text{ °C}$	-	1.6	-	S
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$V_{DS} = 10 \text{ V}; I_D = 500 \text{ mA}; V_{GS} = 4.5 \text{ V};$	-	0.45	0.68	nC
Q _{GS}	gate-source charge	T _j = 25 °C	-	0.15	-	nC
Q_{GD}	gate-drain charge		-	0.15	-	nC
C _{iss}	input capacitance	$V_{DS} = 10 \text{ V}; f = 1 \text{ MHz}; V_{GS} = 0 \text{ V};$	-	55	83	pF
Coss	output capacitance	T _j = 25 °C	-	15	-	pF
C _{rss}	reverse transfer capacitance		-	7	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 10 V; R_L = 250 Ω ; V_{GS} = 4.5 V;	-	6	12	ns
t _r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 °C$	-	4	-	ns
t _{d(off)}	turn-off delay time		-	86	172	ns
t _f	fall time		-	31	-	ns
Source-d	rain diode					
V_{SD}	source-drain voltage	$I_S = 300 \text{ mA}; V_{GS} = 0 \text{ V}; T_i = 25 \text{ °C}$	0.48	0.77	1.2	V

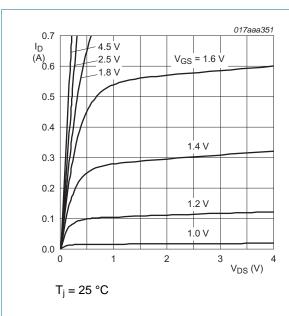
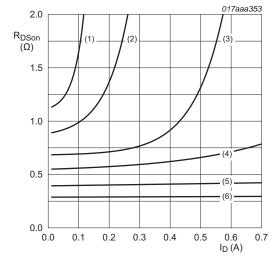


Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_i = 25 \, ^{\circ}C$

(1) $V_{GS} = 1.3 \text{ V}$

(2) $V_{GS} = 1.4 \text{ V}$

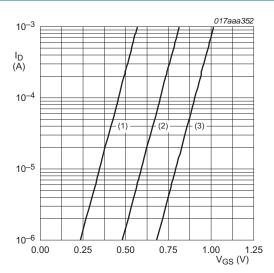
(3) $V_{GS} = 1.6 \text{ V}$

(4) $V_{GS} = 1.8 \text{ V}$

(5) $V_{GS} = 2.5 \text{ V}$

(6) $V_{GS} = 4.5 \text{ V}$

Fig 8. Drain-source on-state resistance as a function of drain current; typical values



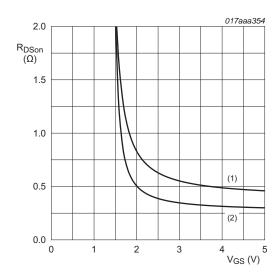
 $T_j = 25 \, ^{\circ}C; \, V_{DS} = 5 \, V$

(1) minimum values

(2) typical values

(3) maximum values

Fig 7. Sub-threshold drain current as a function of gate-source voltage

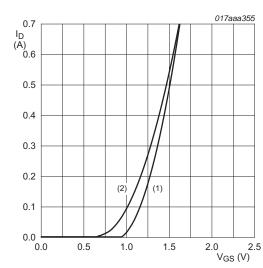


 $I_D = 400 \text{ mA}$

(1) $T_i = 150 \, ^{\circ}C$

(2) $T_i = 25 \, ^{\circ}C$

Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values



 $V_{DS} > I_D \times R_{DSon}$

(1)
$$T_j = 25 \, ^{\circ}C$$

(2)
$$T_i = 150 \, ^{\circ}\text{C}$$

Fig 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values

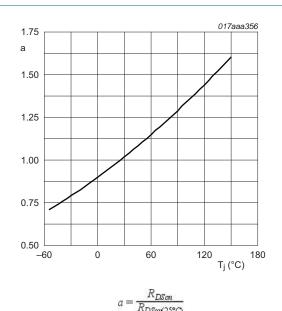
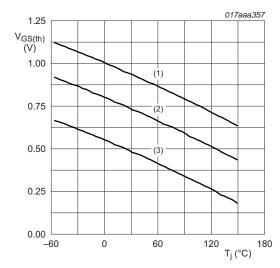


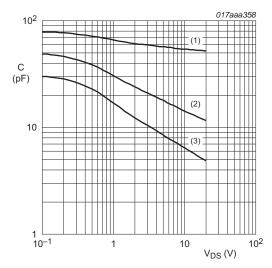
Fig 11. Normalized drain-source on-state resistance as a function of junction temperature; typical values



 $I_D = 0.25 \text{ mA}; V_{DS} = V_{GS}$

- (1) maximum values
- (2) typical values
- (3) minimum values

Fig 12. Gate-source threshold voltage as a function of junction temperature

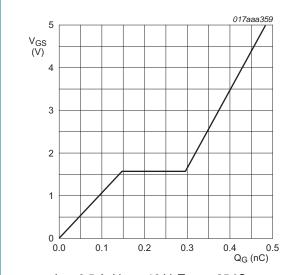


 $f = 1 MHz; V_{GS} = 0 V$

- (1) C_{iss}
- (2) C_{oss}
- (3) C_{rss}

Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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 I_D = 0.5 A; V_{DS} = 10 V; T_{amb} = 25 °C

Fig 14. Gate-source voltage as a function of gate charge; typical values

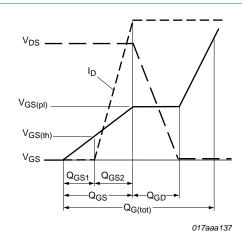
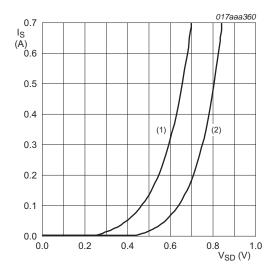


Fig 15. Gate charge waveform definitions



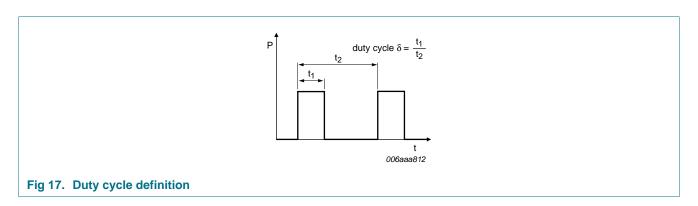
 $V_{GS} = 0 V$

(1) $T_j = 150 \, ^{\circ}\text{C}$

(2) $T_j = 25 \, ^{\circ}C$

Fig 16. Source current as a function of source-drain voltage; typical values

8. Test information



8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q101 - Stress test qualification for discrete semiconductors, and is suitable for use in automotive applications.

9. Package outline

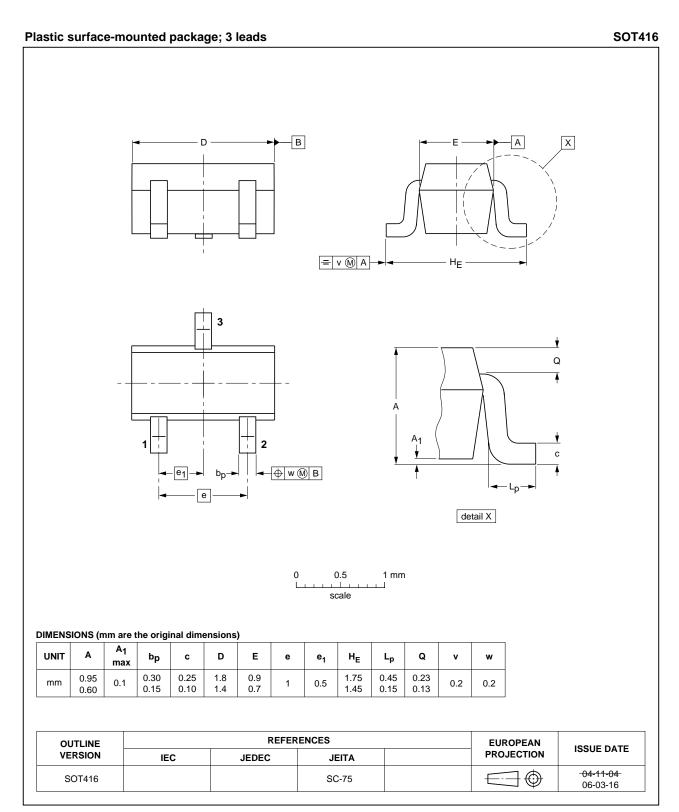
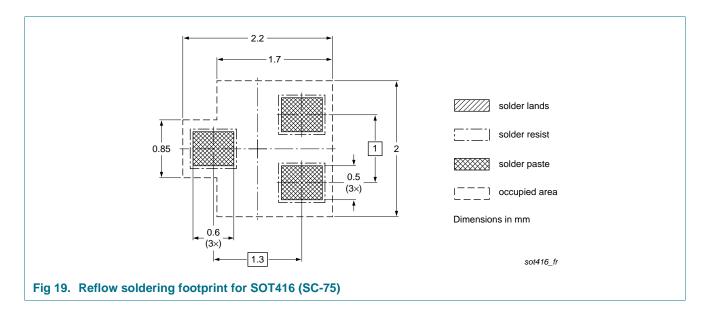


Fig 18. Package outline SOT416 (SC-75)

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10. Soldering



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11. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMR290UNE v.1	20110913	Product data sheet	-	-

20 V, 700 mA N-channel Trench MOSFET

12. Legal information

12.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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